

FCC Part 15B

Measurement and Test Report

For

LM Technologies Ltd.

Unit19, Spectrum House, 32-34, Gordon House Road, London, NW5

1LP, United Kingdom

FCC ID: VVXLM506-5011

Test Rule(s):	<u>FCC Part 15 Subpart B</u>
Product Description:	<u>LM506 Bluetooth 4.0 Class 1 Nano</u> <u>USB Adapter</u>
Tested Model:	<u>506-050x</u>
Report No.:	<u>STR14048285I-3</u>
Tested Date:	<u>2014-05-07 to 2014-06-06</u>
Issued Date:	<u>2014-06-10</u>
Tested By:	<u>Seven Song / Engineer</u> <i>Seven Song</i>
Reviewed By:	<u>Lahm Peng / EMC Manager</u> <i>Lahm peng</i>
Approved & Authorized By:	<u>Jandy so / PSQ Manager</u> <i>Jandyso</i>
Prepared By:	

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Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior permitted by Shenzhen SEM.Test Technology Co., Ltd.

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1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

Client Information

Applicant: LM Technologies Ltd.
 Address of applicant: Unit19, Spectrum House, 32-34, Gordon House Road,
 London, NW5 1LP, United Kingdom
 Manufacturer: LM Technologies Ltd.
 Address of manufacturer: Unit19, Spectrum House, 32-34, Gordon House Road,
 London, NW5 1LP, United Kingdom

General Description of EUT	
Product Name:	LM506 Bluetooth 4.0 Class 1 Nano USB Adapter
Brand Name:	LM
Model No.:	506-050x
<i>Note: The test data is gathered from a production sample provided by the manufacturer.</i>	

Technical Characteristics of EUT	
Rated Voltage:	USB 5V
Rated Current:	/
Lowest Internal Frequency:	26MHz
Highest Internal Frequency:	26MHz
Classification of ITE:	Class B

1.2 Test Standards

The following report is prepared on behalf of the LM Technologies Ltd. in accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules.

The objective is to determine compliance with FCC Part 15, Subpart B, and section 15.205, 15.107, and 15.109 rules.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

1.4 Test Facility

FCC – Registration No.: 934118

Shenzhen SEM.Test Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files and the Registration is 934118.

Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Shenzhen SEM.Test Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

CNAS Registration No.: L4062

Shenzhen SEM.Test Technology Co., Ltd. is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L4062. All measurement facilities used to collect the measurement data are located at 1/F, Building A, Hongwei Industrial Park, Liuxian 2nd Road, Bao'an District, Shenzhen, P.R.C (518101).

1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission level. The test modes were adapted according to the operation manual for use, more detailed description as follows:

Test Mode List:

Test Mode	Description	Remark
TM1	Operating	/

EUT Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
/	/	/	/

Auxiliary Equipment List and Details

Description	Manufacturer	Model	Serial Number
/	/	/	/

Special Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
Notebook	Lenovo	E23	EB12648265

2. SUMMARY OF TEST RESULTS

FCC Rules	Description of Test Item	Result
§ 15.107 (a)	Conducted Emissions	Compliant
§ 15.109 (a)	Radiated Emissions	Compliant

N/A: not applicable

3. Conducted Emissions

3.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement is ± 2.88 dB.

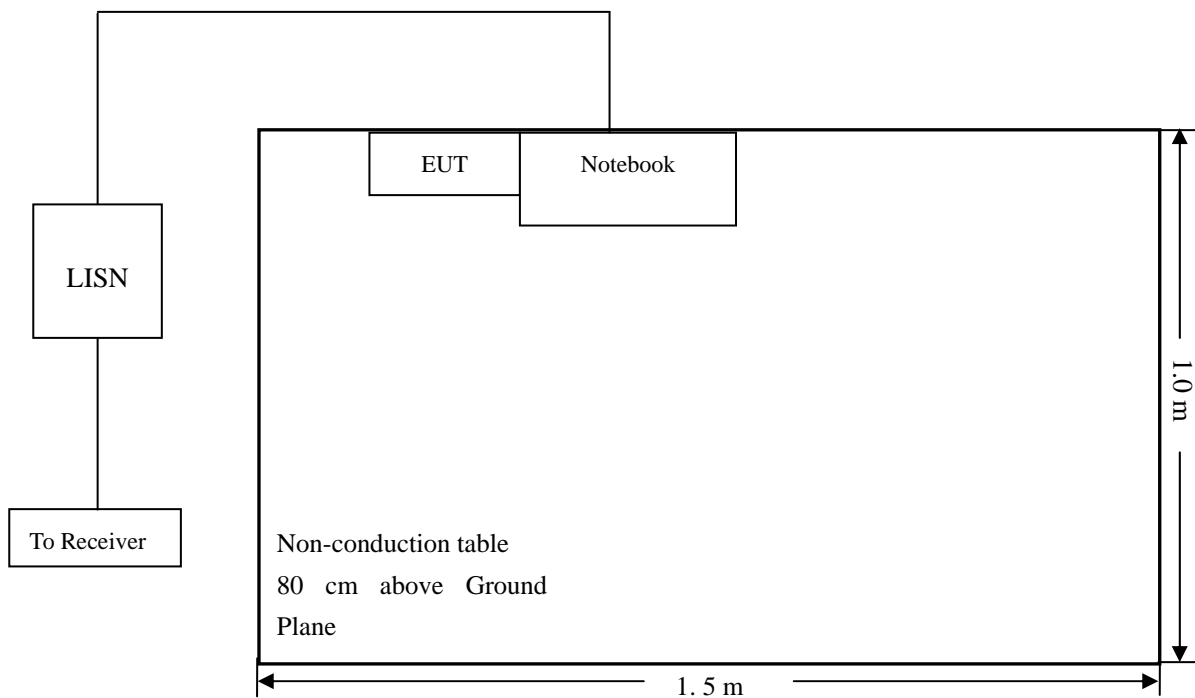
3.2 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2014-05-07	2015-05-06
L.I.S.N	Schwarz beck	NSLK8126	8126-224	2014-05-07	2015-05-06
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2014-05-07	2015-05-06

3.3 Test Procedure

Test is conducting under the description of ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

3.4 Basic Test Setup Block Diagram



3.5 Environmental Conditions

Temperature:	23 °C
Relative Humidity:	52%
ATM Pressure:	1011 mbar

3.6 Summary of Test Results/Plots

According to the data in section 3.7, the EUT complied with the FCC Part 15.107(a) Conducted margin for a Class B device, with the *worst* margin reading of:

-11.16 dB at 2.5380 MHz in the **Line, Peak** detector, 0.15-30MHz

3.7 Conducted Emissions Test Data

Plot of Conducted Emissions Test Data

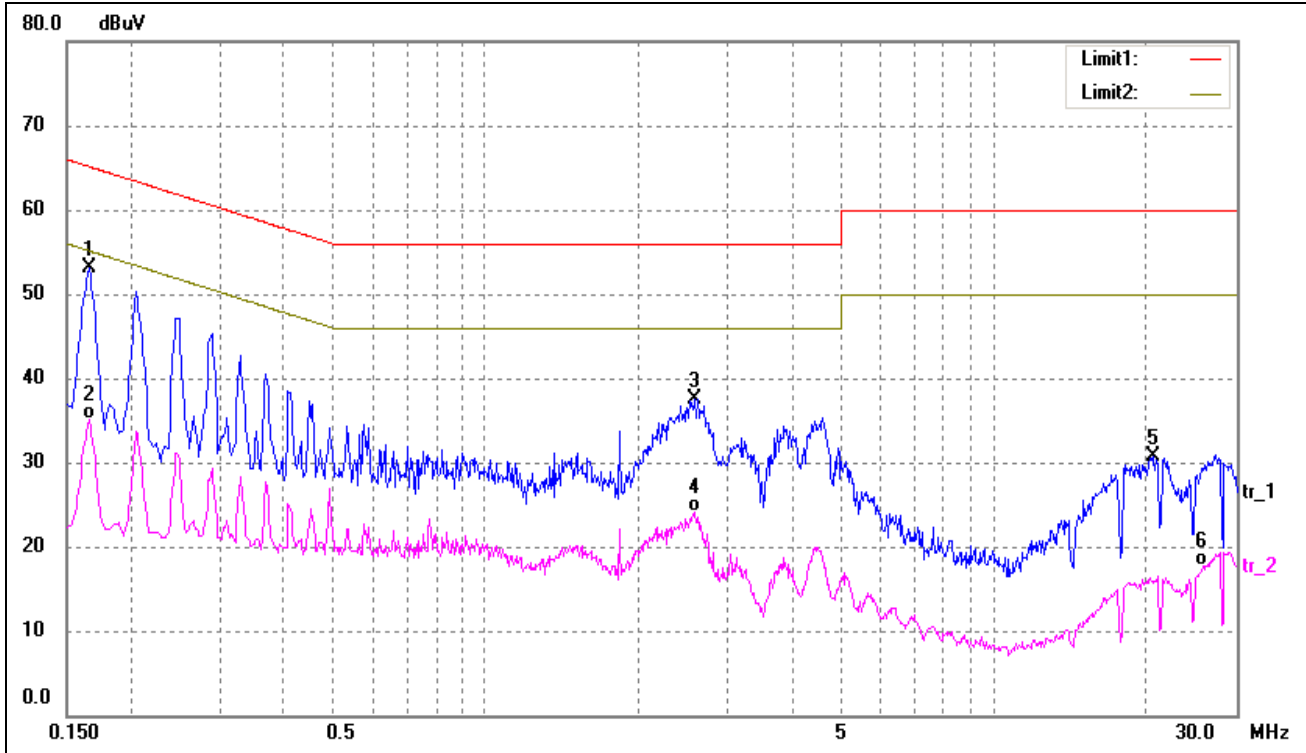
EUT: LM506 Bluetooth 4.0 Class 1 Nano USB Adapter

Tested Model: 506-050x

Operating Condition: TMI

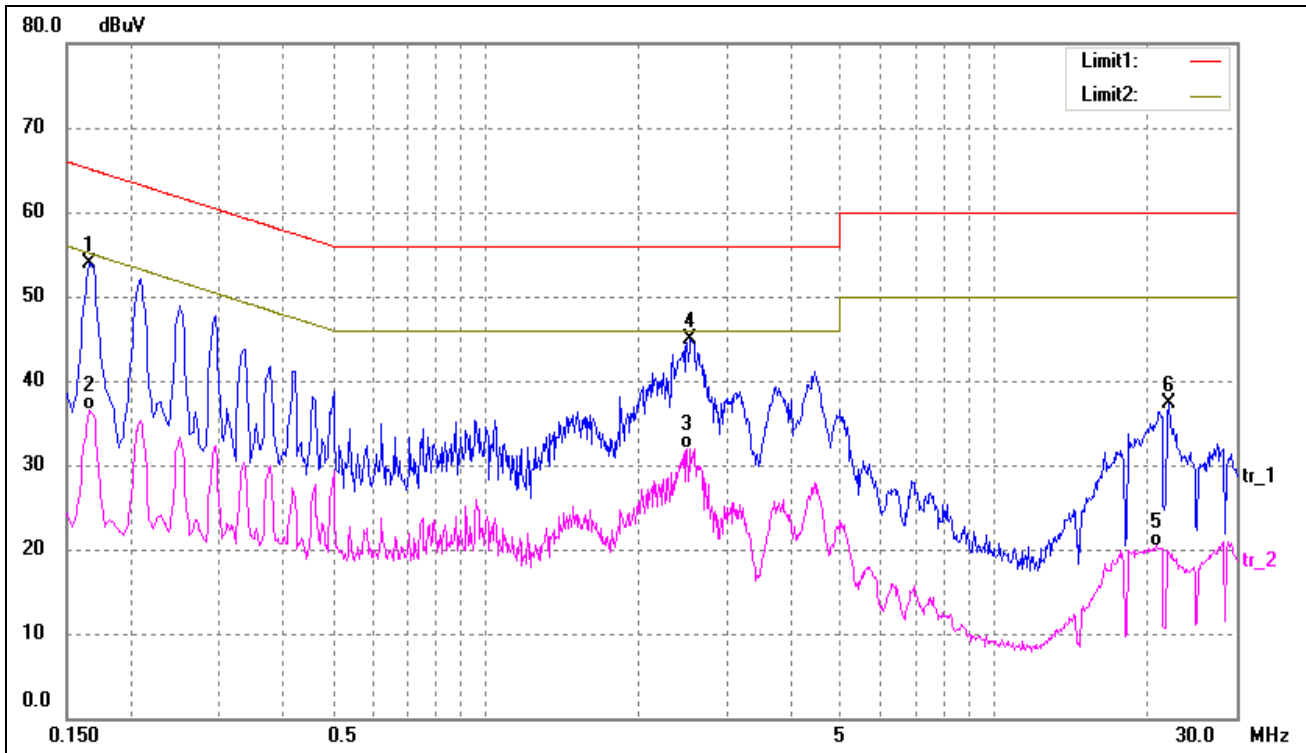
Comment: AC 120V/60Hz; Notebook USB 5V

Test Specification: Neutral



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB/m)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1*	0.1660	43.70	9.50	53.20	65.16	-11.96	peak
2	0.1660	25.58	9.50	35.08	55.16	-20.08	AVG
3	2.5940	27.57	10.00	37.57	56.00	-18.43	peak
4	2.5940	14.09	10.00	24.09	46.00	-21.91	AVG
5	20.5060	18.76	12.00	30.76	60.00	-29.24	peak
6	25.8260	4.75	13.00	17.75	50.00	-32.25	AVG

Test Specification: Line



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB/m)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.1660	44.47	9.50	53.97	65.16	-11.19	peak
2	0.1660	27.02	9.50	36.52	55.16	-18.64	AVG
3	2.4980	21.94	10.00	31.94	46.00	-14.06	AVG
4*	2.5380	34.84	10.00	44.84	56.00	-11.16	peak
5	20.8660	8.40	12.00	20.40	50.00	-29.60	AVG
6	22.0820	25.20	12.03	37.23	60.00	-22.77	peak

4. Radiated Emissions

4.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any radiation emissions measurement is ± 5.10 dB.

4.2 Test Equipment List and Details

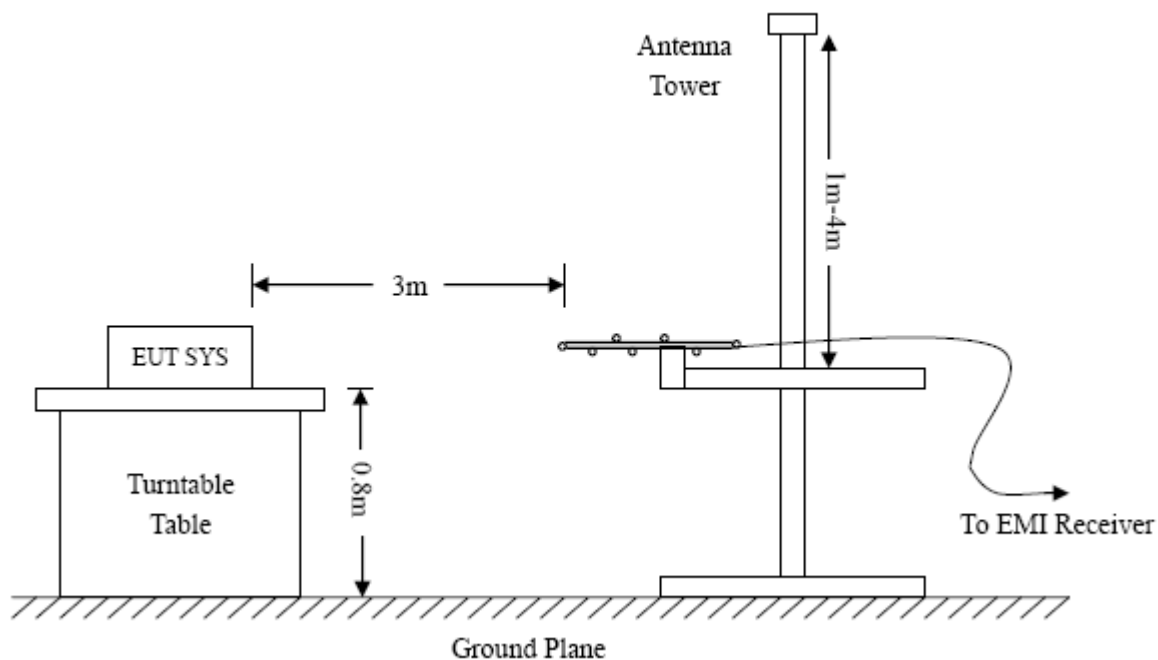
Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
Spectrum Analyzer	R&S	FSP	836079/035	2014-05-07	2015-05-06
EMI Test Receiver	R&S	ESVB	825471/005	2014-05-07	2015-05-06
Pre-amplifier	Agilent	8447F	3113A06717	2014-05-07	2015-05-06
Pre-amplifier	Compliance Direction	PAP-0118	24002	2014-05-07	2015-05-06
Trilog Broadband Antenna	SCHWARZBECK	VULB9163	9163-333	2014-04-20	2015-04-19
Horn Antenna	ETS	3117	00086197	2014-04-20	2015-04-19
Loop Antenna	SCHWARZECK	HFRA 5165	9365	2014-04-20	2015-04-19

4.3 Test Procedure

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.109 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.



4.4 Test Receiver Setup

Frequency :9kHz-30MHz

RBW=10KHz,

VBW =30KHz

Sweep time= Auto

Trace = max hold

Detector function = peak

Frequency :30MHz-1GHz

RBW=120KHz,

VBW=300KHz

Sweep time= Auto

Trace = max hold

Detector function = peak, QP

Frequency :Above 1GHz

RBW=1MHz,

VBW=3MHz(Peak), 10Hz(AV)

Sweep time= Auto

Trace = max hold

Detector function = peak, AV

4.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} - \text{Corr. Factor}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -6dB μ V means the emission is 6dB μ V below the maximum limit for a Class B device. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{FCC Part 15.109(a) Limit}$$

4.6 Environmental Conditions

Temperature:	23 °C
Relative Humidity:	55 %
ATM Pressure:	1011 mbar

4.7 Summary of Test Results/Plots

According to the data, the EUT complied with the FCC Part 15.109(a) rule, and had the worst margin of:

-9.91 dB at 798.9797 MHz in the Horizontal polarization, 9 kHz to 1 GHz, 3Meters

Plot of Radiated Emissions Test Data

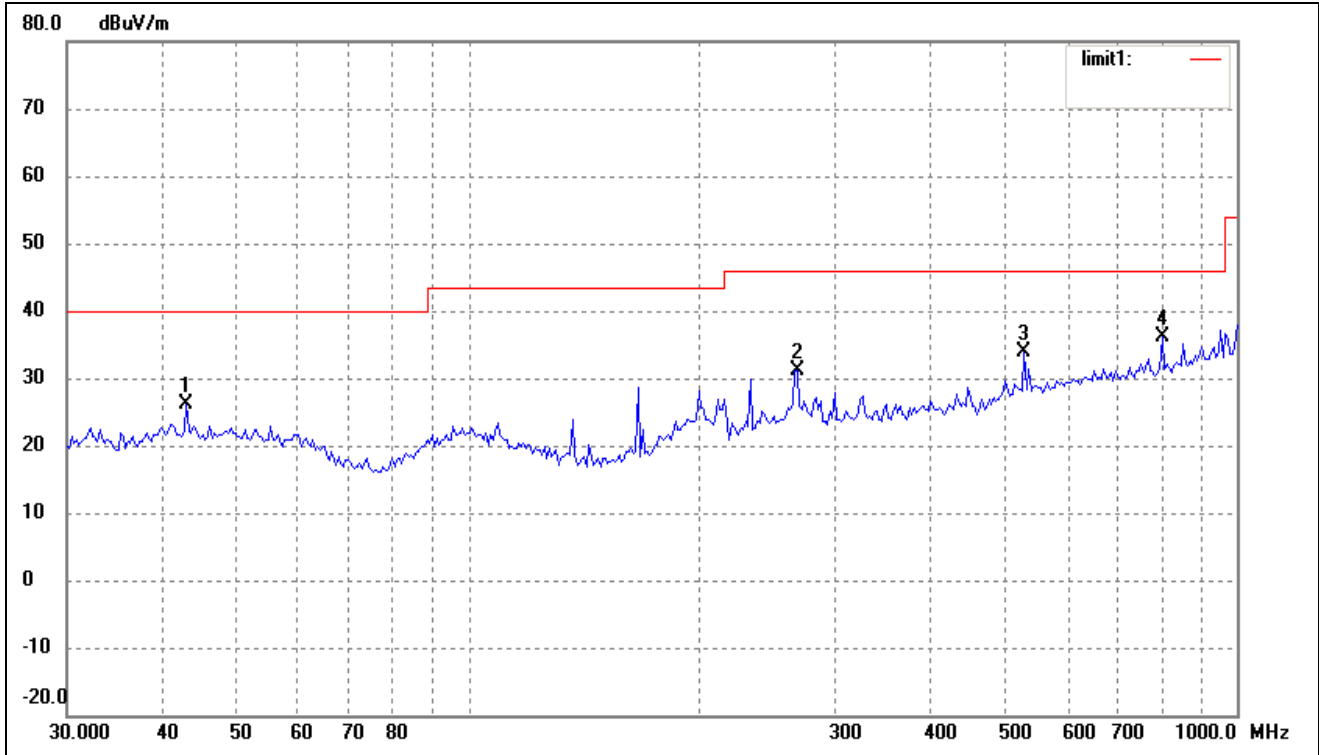
EUT: LM506 Bluetooth 4.0 Class 1 Nano USB Adapter

Tested Model: 506-050x

Operating Condition: TM1

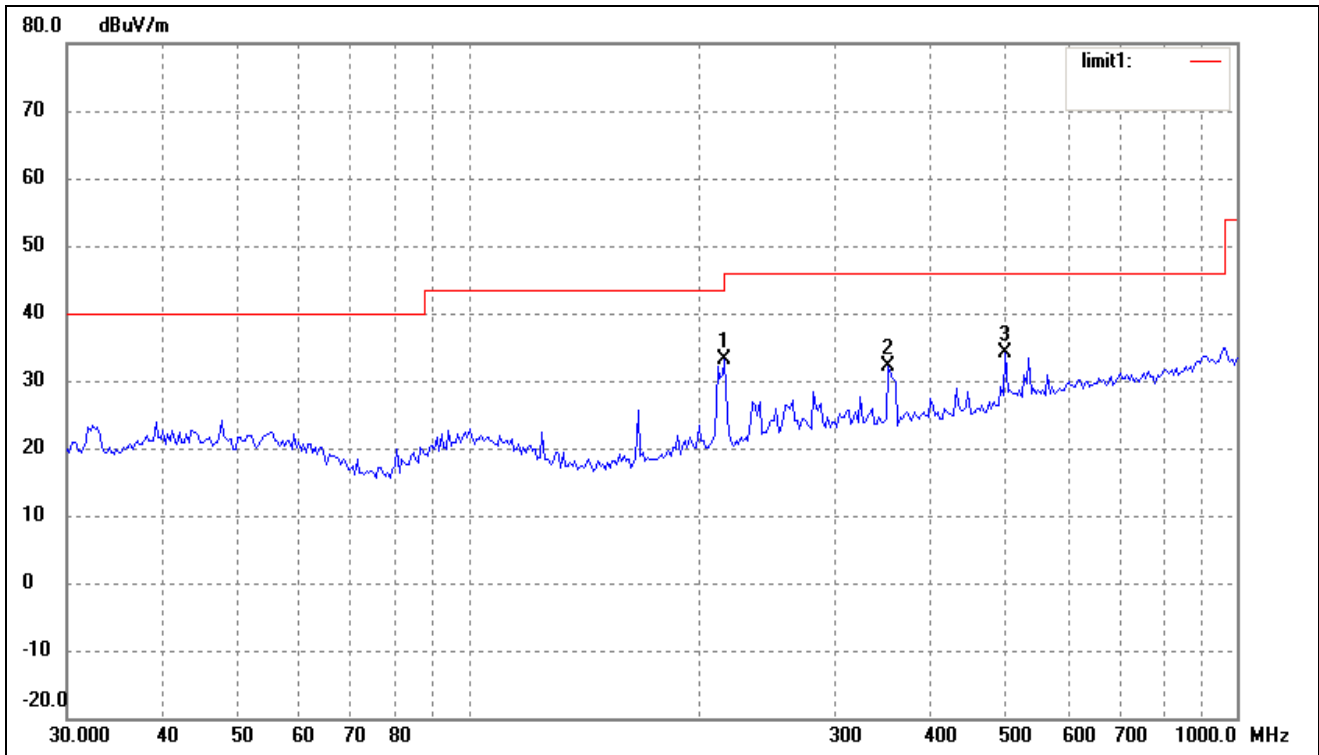
Comment: AC 120V/60Hz; Notebook USB 5V

Test Specification: Horizontal



No.	Frequency (MHz)	Reading (dBuV/m)	Correct dB/m	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (°)	Height (cm)	Remark
1	42.8998	18.15	7.97	26.12	40.00	-13.88	122	100	peak
2	267.5455	23.12	8.12	31.24	46.00	-14.76	21	100	peak
3	528.2458	20.95	12.91	33.86	46.00	-12.14	36	100	peak
4	798.9797	20.59	15.50	36.09	46.00	-9.91	58	100	peak

Test Specification: Vertical



No.	Frequency (MHz)	Reading (dBuV/m)	Correct dB/m	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree (°)	Height (cm)	Remark
1	215.2678	27.03	6.18	33.21	43.50	-10.29	336	100	peak
2	351.7079	22.69	9.48	32.17	46.00	-13.83	28	100	peak
3	499.4247	21.25	12.88	34.13	46.00	-11.87	84	100	peak

Note: Testing is carried out with frequency rang 9kHz to the 1GHz.

***** END OF REPORT *****